

**Notice of References Cited**

Application/Control No.

09/767,512

Applicant(s)/Patent Under  
Reexamination  
VONG ET AL.

Examiner

Christopher B Shin

Art Unit

2182

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,552,967	09-1996	Seto et al.	361/818
	B	US-6,041,215	03-2000	Maddrell et al.	434/317
	C	US-5,471,674	11-1995	Stewart et al.	713/2
	D	US-6,029,215	02-2000	Watts et al.	710/303
	E	US-5,841,849	11-1998	Macor, James Joseph	379/142.17
	F	US-5,917,453	06-1999	Uchino et al.	343/721
	G	US-6,018,584	01-2000	Paulick, Thomas Eugene	381/122
	H	US-4,750,094	06-1988	Krasik, Michael H.	362/95
\	I	US-6,016,388 ✓	01-2000	Dillon, Douglas M.	709/242
	J	US-4,697,374	10-1987	Simms, Robert A.	43/17.5
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.